

# BT258S-800LT

# SCR logic level, high temperature Rev. 01 — 2 September 2008

**Product data sheet** 

## **Product profile**

#### 1.1 General description

Passivated sensitive gate Silicon-Controlled Rectifier in a SOT428 surface-mounted plastic package

#### 1.2 Features

- Very sensitive gate
- Direct interfacing to logic level ICs
- High operating temperature
- Direct interfacing to low-power gate drive circuits

#### 1.3 Applications

- General purpose switching and phase control
- Protection circuits for Switched-Mode Power Supplies (SMPS)
- Ignition circuits
- Protection circuits in lighting ballasts

#### 1.4 Quick reference data

- V<sub>DRM</sub> ≤ 800 V
- $V_{RRM} \le 800 \text{ V}$
- $I_{TSM} \le 75 \text{ A (t = 10 ms)}$
- T<sub>j(max)</sub> = 150 °C

- I<sub>GT</sub>  $\leq$  50  $\mu$ A
- $I_{T(AV)} \le 5 A$
- $I_{T(RMS)} \le 8 A$

## **Pinning information**

Table 1. **Pinning** 

	9				
Pin	Description	Simplified outline	Graphic symbol		
1	cathode (K)		. N		
2	anode (A)	mb	A → K		
3	gate (G)		G sym037		
mb	mounting base; connected to anode (A)	1 3			
		SOT428 (DPAK)			



## 3. Ordering information

#### Table 2. Ordering information

Type number	Package					
	Name	Description	Version			
BT258S-800LT	DPAK	plastic single-ended surface-mounted package (DPAK); 3 leads (one lead cropped)	SOT428			

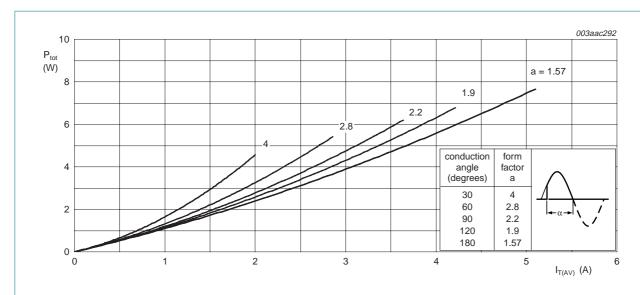
## 4. Limiting values

#### Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

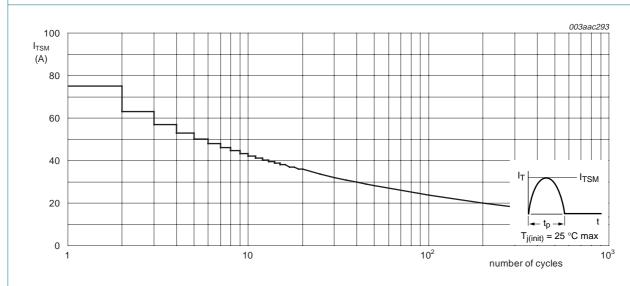
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DRM}$	repetitive peak off-state voltage		-	800	V
$V_{RRM}$	repetitive peak reverse voltage		-	800	V
$I_{T(AV)}$	average on-state current	half sine wave; $T_{mb} \le 135 ^{\circ}C$ ; see Figure 1		5	Α
$I_{T(RMS)}$	RMS on-state current	all conduction angles; see Figure 4 and $\underline{5}$	-	8	Α
I <sub>TSM</sub>	non-repetitive peak on-state current	half sine wave; $T_j = 25$ °C prior to surge; see Figure 2 and 3			
		t = 10 ms	-	75	Α
		t = 8.3 ms	-	82	Α
I <sup>2</sup> t	I <sup>2</sup> t for fusing	$t_p = 10 \text{ ms}$	-	28	A <sup>2</sup> s
dl <sub>T</sub> /dt	rate of rise of on-state current	$I_{TM} = 10 \text{ A}; I_G = 50 \text{ mA};$ $dI_G/dt = 50 \text{ mA/}\mu\text{s}$		50	A/μs
$I_{GM}$	peak gate current		-	2	Α
$P_{GM}$	peak gate power		-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.5	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
Tj	junction temperature		<u>[1]</u> _	150	°C

<sup>[1]</sup> Operation above  $T_j$  = 110 °C may require the use of a gate to cathode resistor of 1 k $\Omega$  or less.



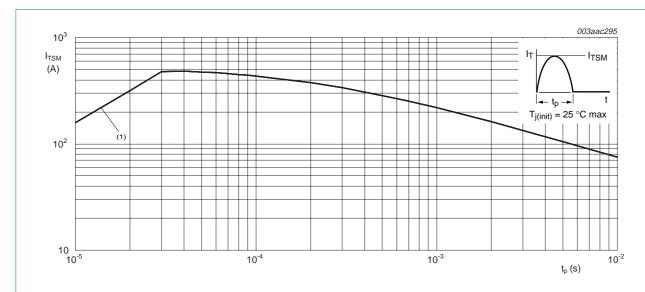
 $\alpha$  = conduction angle

Fig 1. Total power dissipation as a function of average on-state current; maximum values



f = 50 Hz

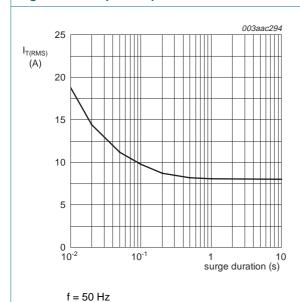
Fig 2. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values



 $t_p \leq 20 \; ms$ 

(1) dl<sub>T</sub>/dt limit

Fig 3. Non-repetitive peak on-state current as a function of pulse width; maximum values



T<sub>mb</sub> = 135 °C

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Fig 4. RMS on-state current as a function of surge duration; maximum values

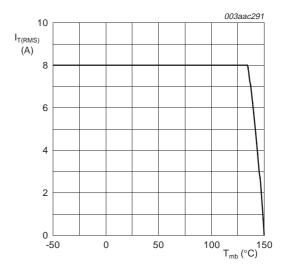


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values

## 5. Thermal characteristics

Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see <u>Figure 6</u>	-	-	2	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	75	-	K/W

[1] Mounted on a FR4 printed-circuit board, single-sided copper, tin-plated and standard footprint; see Figure 14.

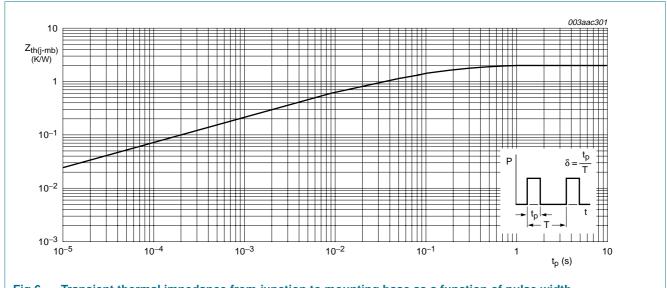


Fig 6. Transient thermal impedance from junction to mounting base as a function of pulse width

## 6. Characteristics

Table 5. Characteristics

 $T_i = 25 \,^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static ch	naracteristics					
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 8}}{}$	20	-	50	μΑ
IL	latching current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure 10}}{\text{Figure 10}}$	-	0.4	10	mA
I <sub>H</sub>	holding current	$V_D = 12 \text{ V}; I_G = 0.1 \text{ A}; \text{ see } \frac{\text{Figure } 11}{\text{Figure } 11}$	-	0.3	6	mA
$V_{T}$	on-state voltage	I <sub>T</sub> = 16 A; see <u>Figure 9</u>	-	1.3	1.6	V
$V_{GT}$	gate trigger voltage	I <sub>T</sub> = 0.1 A; see <u>Figure 7</u>				
		V <sub>D</sub> = 12 V	-	0.4	1.5	V
		$V_D = V_{DRM}$ ; $T_j = 110  ^{\circ}C$	0.1	0.2	-	V
$I_D$	off-state current	$V_D = V_{DRM(max)}$ ; $T_j = 150  ^{\circ}C$	-	0.5	2.5	mA
I <sub>R</sub>	reverse current	$V_R = V_{RRM(max)}$ ; $T_j = 150  ^{\circ}C$	-	0.5	2.5	mA
Dynamic	characteristics					
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$V_{DM}$ = 0.67 $\times$ $V_{DRM(max)};$ $T_{j}$ = 150 °C; exponential waveform; $R_{GK}$ = 100 $\Omega$	35	70	-	V/μs
t <sub>gt</sub>	gate-controlled turn-on time	$I_{TM} = 10 \text{ A}; V_D = V_{DRM(max)}; I_G = 5 \text{ mA};$ $dI_G/dt = 0.2 \text{ A}/\mu\text{s}$	-	2	-	μs
		<u> </u>				

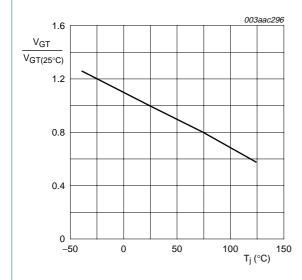


Fig 7. Normalized gate trigger voltage as a function of junction temperature

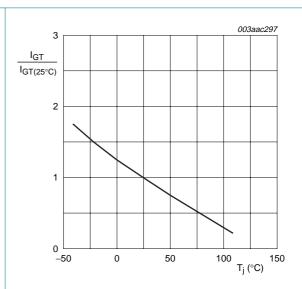
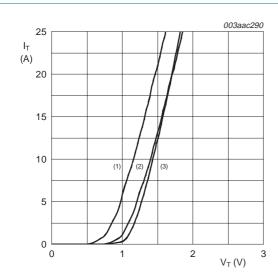


Fig 8. Normalized gate trigger current as a function of junction temperature



 $V_0 = 1.0 \ V$ 

 $R_s = 0.04 \Omega$ 

(1)  $T_j = 150 \,^{\circ}\text{C}$ ; typical values

(2)  $T_i = 150 \,^{\circ}C$ ; maximum values

(3)  $T_i = 25$  °C; maximum values

Fig 9. On-state current as a function of on-state voltage

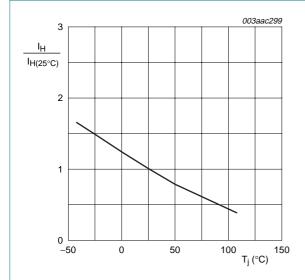


Fig 11. Normalized holding current as a function of junction temperature

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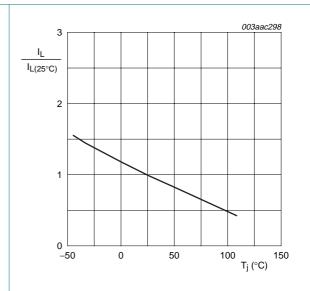
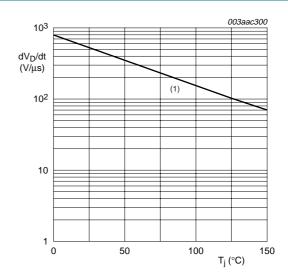


Fig 10. Normalized latching current as a function of junction temperature



(1)  $R_{GK} = 100 \Omega$ 

Fig 12. Critical rate of rise of off-state voltage as a function of junction temperature; typical values

## 7. Package outline

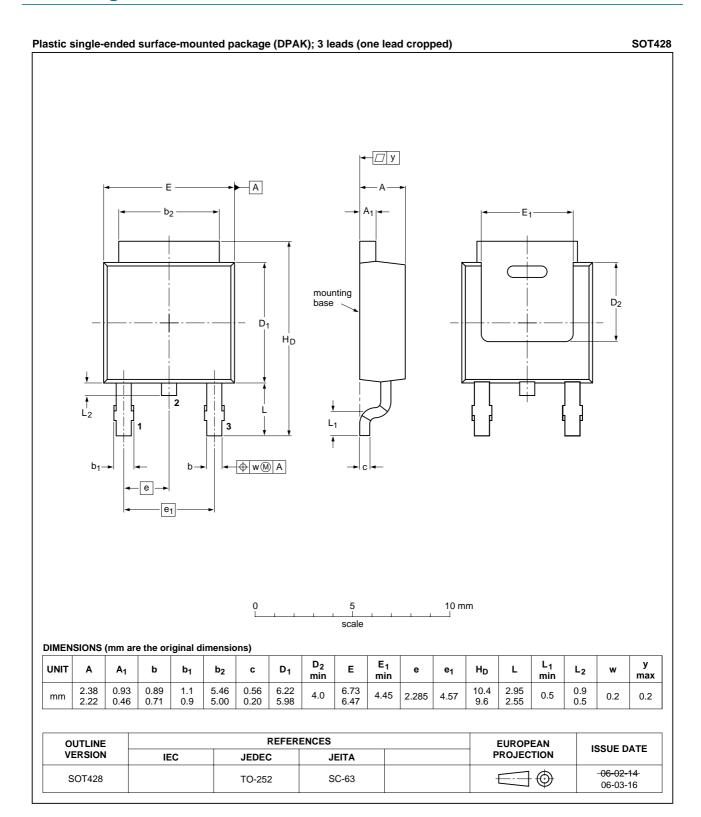
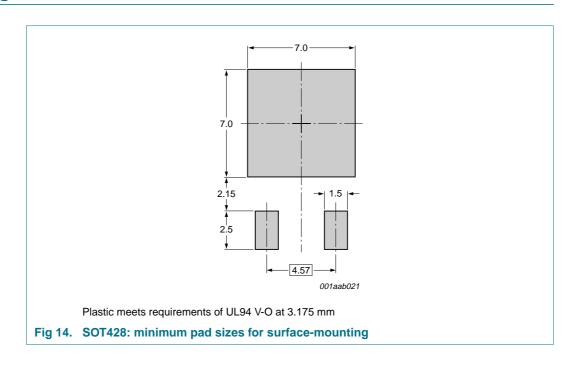


Fig 13. Package outline SOT428 (DPAK)

## 8. Mounting



BT258S-800LT

SCR logic level, high temperature

# 9. Revision history

#### Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BT258S-800LT_1	20080902	Product data sheet	-	-

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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# BT258S-800LT

#### SCR logic level, high temperature

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